

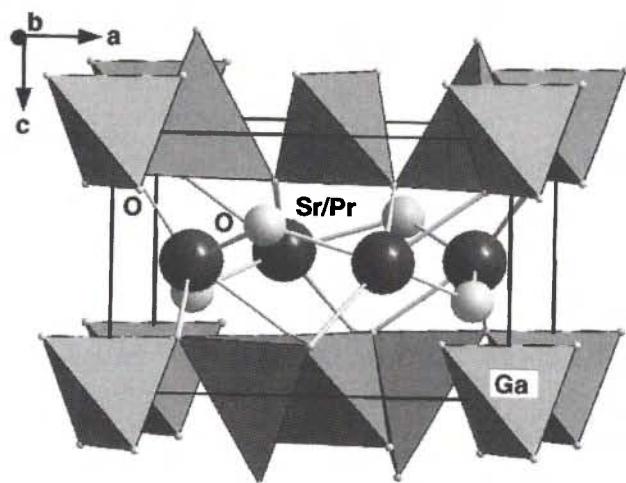
Crystal structure of strontium praseodym trigallium heptaoxide, $(\text{Sr}_{0.5}\text{Pr}_{0.5})_2\text{Ga}_3\text{O}_7$

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Abstract

$\text{Ga}_3\text{O}_7\text{PrSr}$, tetragonal, $P\bar{4}2_1m$ (No. 113), $a = 8.0198(2)$ Å, $c = 5.2991(1)$ Å, $V = 340.8$ Å³, $Z = 2$, $R(P) = 0.026$, $wR(P) = 0.040$, $R(I) = 0.025$, $T = 295$ K.

Source of material

$\text{SrPrGa}_3\text{O}_7$ was synthesized by melting a mixture of the oxides and carbonates (4N and 5N quality) under flowing nitrogen in an Ir crucible. A mixture containing SrO , Pr_2O_3 and Ga_2O_3 in a molar ratio of 2:1:3 was used. The solidified melt was homogeneous and of green color. Because of the incongruent melting of SrPrGaO_4 - one of the most favoured candidates for substrates for high- T_c superconductors - a shift in the melt composition during the growth process takes place. In consequence, $\text{SrPrGa}_3\text{O}_7$ is formed in the multiphase residual melt [1].

Starting atomic coordinates for the refinement were taken from $\text{SrLaCa}_3\text{O}_7$ [2]. The displacement parameters of all atoms were fixed to reliable values.

Table 1. Data collection and handling.

Powder:	green
Wavelength:	$\text{Cu } K_\alpha$ radiation (1.54059 Å)
μ :	771.1 cm ⁻¹
Diffractometer:	Stoe Stadi P
Scan mode:	transmission Debye-Scherrer mode
$2\theta_{\max}$, stepwidth:	89.98°, 0.02
$N(\text{points})_{\text{measured}}$	3750
$N(hkl)_{\text{measured}}$	104
$N(\text{param})_{\text{refined}}$:	39
Program:	RIETAN-97 [3]

Table 2. Atomic coordinates and displacement parameters (in Å²).

Atom	Site	Occ.	x	y	z	U_{iso}
Sr(1)	4e	0.5	0.1621(9)	$x+1/2$	0.509(3)	0.006
Pr(1)	4e	0.5	0.1621	$x+1/2$	0.509	0.006
Ga(1)	4e		0.644(1)	$x+1/2$	0.975(5)	0.009
Ga(2)	2a		0	0	0	0.009
O(1)	8f		0.084(5)	0.160(6)	0.212(7)	0.012
O(2)	4e		0.634(7)	$x+1/2$	0.356(8)	0.012
O(3)	2c		0	1/2	0.193(7)	0.012

References

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